ARMI MBH

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Certificate of Analysis

Revision No.: 000

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ISO ISO ISO/IEC 17034:2016 17025:2017 9001:2015

Product ID: MBH-32X SN7-22

Certified Reference Material

Product Description: Bronze Alloy, Leaded Tin Bronze, CDA 925/C92500

Description and Intended Use: This Certified Reference Material is covered under the scope of accreditation to ISO 17034 by LGC Standards - Manchester. NH. As an ISO 17034 certified reference material, appropriate use of this material will fulfill the certified reference material and traceability requirements for use in ISO 17025 accredited laboratories. This CRM may come in the form of a solid disk, or chips. The intended use of this CRM may include, but is not limited to, the calibration of instruments and the validation of analytical methods. Cartified Values listed in wt % with acceptiated upcortainties

Certified values listed in wt.% with associated uncertainties									
Ag	0.008 ± 0.001	Bi	0.0028 ± 0.	0009 Cu	87.4 ± 0.2	Ni	1.22 :	± 0.04	
Ρ	0.030 ± 0.003	Pb	1.28 ± 0.	03 S	0.003 ± 0.001	Sb	0.0045 :	± 0.0005	
Sn	10.0 ± 0.1	Zn	0.025 ± 0.	002					

Indicative Values listed in ppm

As 11 Co 4 AI 10

Homogeneity and Uncertainty: "Uncertainty" values, as reported adjacent to certified concentration values, are based on a 95% Confidence Interval. These estimated uncertainties include the combined effects of method imprecision, material inhomogeneity, and any bias between methods. Homogeneity data from experimental XRF results are reflected in both the overall statistics and certified data. Homogeneity samples are selected by a systematic sampling procedure. The number of samples may be determined by equation 1, where Nprod is the number of units produced and Nmin is the number of samples used for homogeneity testing. These samples are arranged in a simple randomized design such that each sample is analyzed multiple times by XRF. Homogeneity may also be determined within sample using an applied version of ASTM E826. A single factor ANOVA is used to calculated uncertainty due to inhomogeneity (Uhom). Uncertainty of the material is calculated by equation 2, where H=U_{hom}, S= Standard deviation, t= t-value at 95% CI, and n= number of observations.

$$1.N_{MIN} = \max(10, \sqrt[3]{N_{PROD}})$$

$$2.U_{CRM} = \frac{\sqrt{H^2 + S^2}}{\sqrt{n}} * t$$

Certification Laboratories: Much of the analytical work performed to assess this material has been carried out by laboratories with proven competence, as indicated by their accreditation to ISO 17025. It is an implicit requirement for this accreditation that analytical work should be performed with due traceability, via an unbroken chain of comparisons, each with stated uncertainty, to primary standards such as the mole, or to nationally- or internationally-recognised reference materials. Of the individual results herein, some have traceability (to the mole) via primary analytical methods. Some are traceable to substances of known stoichiometry. Most have traceability via commercial solutions. Furthermore, some results have additional traceability to NIST standards, as part of the analytical calibration or process control.

- AnchorCert Birmingham, England . Dirats Laboratories - Westfield, MA
 - Genitest Inc Montreal, Canada .
 - EAG Laboratories Liverpool, NY
- Instytut Metalurgii Zelaza Gliwice, Poland
- . Laboratory Testing, Inc. - Hatfield, PA Elemental Analysis Inc. - Lexington, KY • LGC Standards - Manchester, NH
- Lithea S.R.O. Brno, Czech Republic
- NSL Analytical Services Cleveland, OH .
- Sheffield Assay Office Sheffield, England
- Universal Scientific Laboratory Pty Ltd New South Wales, Australia

Instructions for Use: The test surface is on the opposite side of the labeled surface, which includes the material identification. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing, as these processes may contaminate the surface. The minimum sample size for chips should be individually evaluated based on the analytical technique used; this would typically be greater than 0.1 grams. The material should be stored in a cool, dry location when not in use.

Chips are not recommended for gas analysis.

Period of Validity: The certification of this material is valid indefinitely, within the uncertainty specified, provided the material is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the material is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

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Chuck Goudreau, Certifying Officer

18 January 2024 **Certification Date**



ISO 17034 Accredited: Reference Materials Producer, Certificate # 2848.02 ISO/IEC 17025 Accredited: Chemical Testing, Certificate # 2848.01

Conditions of Sale and Supply: All CRMs & RMs sold are subject to applicable LGC Standard Terms and Conditions of Sale.

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The following data represents all pertinent information reported as it applies to the chemical characterization of this material.

	Ag	AI	As	Bi	Co	Cu	Ni	Р	Pb	S	Sb	Sn	Zn
1	0.0035	0.0002	0.0005	0.0020	0.0001	87.10	1.0740	0.0241	1.218	0.0011	0.0040	9.670	0.0215
2	0.0058	0.0006	0.0005	0.0020	0.0002	87.11	1.1590	0.0246	1.240	0.0022	0.0040	9.766	0.0222
3	0.0070	0.0011	0.0010	0.0021	0.0003	87.18	1.1909	0.0280	1.260	0.0026	0.0043	9.833	0.0224
4	0.0071	0.0016	0.0016	0.0021	0.0004	87.37	1.2000	0.0280	1.260	0.0028	0.0043	9.870	0.0230
5	0.0075	0.0017	0.0020	0.0026	0.0012	87.38	1.2120	0.0281	1.262	0.0030	0.0048	9.932	0.0230
6	0.0080	<0.0005	<0.0001	0.0027	<0.0001	87.43	1.2140	0.0300	1.291	0.0044	0.0050	9.940	0.0239
7	0.0080	<0.0005	<0.0005	0.0045	<0.0005	87.61	1.2326	0.0303	1.300	0.0057	0.0052	10.000	0.0252
8	0.0080	<0.0010	<0.005	0.0045	<0.0010	87.65	1.2350	0.0310	1.306	<0.001	<0.005	10.040	0.0260
9	0.0081	<0.005	<0.0050	<0.005	<0.005		1.2406	0.0310	1.318			10.063	0.0270
10	0.0084						1.2851	0.0350	1.320			10.120	0.0281
11	0.0113						1.3000	0.0361	1.328			10.122	0.0287
12	0.0118						1.3190	0.0391				10.150	0.0310
13												10.200	
Mean	0.0079	0.0010	0.0011	0.0028	0.0004	87.35	1.2219	0.0304	1.282	0.0031	0.0045	9.977	0.0252
STDV	0.0022	0.0006	0.0007	0.0011	0.0004	0.21	0.0658	0.0045	0.036	0.0015	0.0005	0.160	0.0030
Certified	0.008	(0.0010)	(0.0011)	0.0028	(0.0004)	87.4	1.22	0.030	1.28	0.003	0.0045	10.0	0.025
U _{CRM}	0.001			0.0009		0.2	0.04	0.003	0.03	0.001	0.0005	0.1	0.002
Methods	I,IM,X		I,IM	IM,I	I,IM	I,W	I,O	I,IM,W,X		C,I	I,IM	I,W,X,O	I,IM,X

Legend: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, IM=ICP-MS, D = DC Arc, O = AES, X = XRF, G = GDAES or GDMS, H = Hollow Cathode AES

